Search Notes

1	Application/Control No.	Applicant(s)/Patent under Reexamination		
	10/670,464	CHANG, SEOK-IL	-IL	
	Examiner	Art Unit		

DON N. VO

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SEARCHED					
Class	Subclass	Date	Examiner		
375	141-145, 147-150, 152	2/6/2007	DV		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
INVENTOR NAME SEARCHED	1/22/2007	DV
EAST	1/26/2007	DV